

# EMC Test Report

**Application No.** : HX201002060386

**Applicant** : Shenzhen Meiduojiang Technology Co., Ltd.

**Equipment Under Test (EUT)**

**EUT Name** : Facial Cleansing Brush

**Model No.** : GT1933

**Serial No.** : N/A

**Brand Name** : N/A

**Receipt Date** : 2020-09-30

**Test Date** : 2020-09-30 to 2020-10-13

**Issue Date** : 2020-10-13

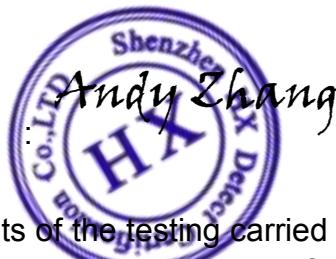
**Standards** : EN 55014-1: 2017  
EN 55014-2: 2015

**Conclusions** : **PASS**

In the configuration tested, the EUT complied with the standards specified above. The EUT technically complies with the 2014/30/EU directive requirements.

**Test/Witness Engineer** : *Tim Chen*

**Approved & Authorized** :



This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.

---

---

## TABLE OF CONTENTS

<b>1. GENERAL INFORMATION.....</b>	<b>3</b>
1.1. Client Information.....	3
1.2. General Description of EUT (Equipment Under Test).....	3
1.3. Block Diagram Showing the Configuration of System Tested.....	3
1.4. Description of Support Units.....	3
1.5. Performance Criterion.....	4
1.6. Classification of Apparatus.....	4
1.7. Test Facility.....	4
<b>2. TEST RESULTS SUMMARY.....</b>	<b>5</b>
<b>3. TEST EQUIPMENT USED.....</b>	<b>6</b>
<b>4. CONDUCTED EMISSION TEST.....</b>	<b>8</b>
4.1. Test Standard and Limit.....	8
4.2. Test Setup.....	8
4.3. Test Procedure.....	8
4.4. Test Condition.....	9
4.5. Test Data.....	9
<b>5. RADIATED EMISSION TEST.....</b>	<b>12</b>
5.1. Test Standard and Limit.....	12
5.2. Test Setup.....	12
5.3. Test Procedure.....	12
5.4. Test Condition.....	13
5.5. Test Data.....	13
<b>6. ELECTROSTATIC DISCHARGE IMMUNITY TEST.....</b>	<b>16</b>
6.1. Test Requirements.....	16
6.2. Test Setup.....	16
6.3. Test Procedure.....	16
6.4. Test Data.....	17
<b>7. RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST.....</b>	<b>19</b>
7.1. Test Requirements.....	19
7.2. Test Setup.....	19
7.3. Test Procedure.....	19
7.4. Test Data.....	20
<b>8. PHOTOGRAPHS - CONSTRUCTIONAL DETAILS.....</b>	<b>22</b>

# 1. General Information

## 1.1. Client Information

Applicant	:	Shenzhen Meiduojiang Technology Co., Ltd.
Address	:	Room 108, Office Building 96, Yangyong Road, Tangxiayong Community, Yanluo Street, Baoan District, Shenzhen
Manufacturer	:	Shenzhen Meiduojiang Technology Co., Ltd.
Address	:	Room 108, Office Building 96, Yangyong Road, Tangxiayong Community, Yanluo Street, Baoan District, Shenzhen

## 1.2. General Description of EUT (Equipment Under Test)

EUT Name	:	Facial Cleansing Brush
Model No.	:	GT1933
Serial No.	:	N/A
Brand Name	:	N/A
Power Supply	:	DC 3V, 135-180mA
<b>Remark:</b> All above models are identical in schematic, structure and critical components except for only different appearance; therefore, EMC testing was performed with GT1933 only.		

## 1.3. Block Diagram Showing the Configuration of System Tested



## 1.4. Description of Support Units

The EUT has been tested as an independent unit.

## 1.5. Performance Criterion

**Criterion A:** The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

**Criterion B:** After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

**Criterion C:** Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

## 1.6. Classification of Apparatus

**Category I:** Apparatus containing no electronic control circuitry.

**Category II:** Transformer toys, dual supply toys, mains powered motor operated appliances, tools, heating appliances and similar electric apparatus (for example-UV radiators, IR radiators and microwave ovens) containing electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15MHz.

**Category III:** Battery powered apparatus (with built-in batteries or external batteries), which in normal use is not connected to the mains, containing an electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15MHz.

This category includes apparatus provided with rechargeable batteries which can be charged by connecting the apparatus to the mains power. However, this apparatus shall also be tested as an apparatus in category III while it is connected to the mains network.

**Category IV:** All other apparatus covered by the scope of this standard.

## 1.7. Test Facility

The testing report were performed by the The testing report were performed by the Shenzhen HX Detect Certification Co., Ltd., in their facilities located at 5/F, Building B15, Zongtai Cultural and Creative Industrial Park, Yintian Creative Park, Xixiang Town, Bao 'an District, Shenzhen.

## 2. Test Results Summary

<b>EMISSION</b>		
<b>Description of test items</b>	<b>Standards</b>	<b>Results</b>
Conducted disturbance at mains terminals	EN 55014-1: 2017	N/A
Disturbance Power	EN 55014-1: 2017	N/A
Click measurement	EN 55014-1: 2017	N/A
Radiated disturbance	EN 55014-1: 2017	Pass
Harmonic current emissions	EN61000-3-2: 2019	N/A
Voltage fluctuation and flicker	EN61000-3-3: 2013	N/A
<b>IMMUNITY</b>		
<b>Description of test items</b>	<b>Basic Standards</b>	<b>Results</b>
Electrostatic Discharge (ESD)	EN61000-4-2: 2009	Pass
Radio-frequency, Continuous Radiated Disturbance	EN61000-4-3: 2006 + A1: 2008 + A2: 2010	Pass
EFT/B Immunity	EN61000-4-4: 2012	N/A
Surge Immunity	EN61000-4-5: 2014	N/A
Conducted RF Immunity	EN61000-4-6: 2014	N/A
Voltage dips, 40% reduction	EN61000-4-11: 2004	N/A
Voltage dips, 70% reduction		
Voltage interruptions		
<b>Note:</b> N/A is an abbreviation for Not Applicable.		

### 3. Test Equipment Used

<b>3.1. Test Equipment Used to Measure Conducted Emission</b>					
<b>No.</b>	<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Last Cal.</b>	<b>Cal. Interval</b>
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan.02, 2020	1 Year
HX-EMC002	AMN	Rohde & Schwarz	ENV216	Jan.02, 2020	1 Year
HX-EMC003	AMN	SCHWARZBECK	NNBL 8226	Jan.02, 2020	1 Year
<b>3.2. Test Equipment Used to Measure Disturbance Power</b>					
<b>No.</b>	<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Last Cal.</b>	<b>Cal. Interval</b>
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan.02, 2020	1 Year
HX-EMC028	Power Clamp	Luthi	MDS-21	Jan.02, 2020	1 Year
<b>3.3. Test Equipment UseTest Equipment Used to Measure Radiated Emission</b>					
<b>No.</b>	<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Last Cal.</b>	<b>Cal. Interval</b>
HX-EMC004	EMI Test Receiver	Rohde & Schwarz	ESI26	Jan.02, 2020	1 Year
HX-EMC005	Bilog Antenna	SCHWARZBECK	VULB9163	Jan.02, 2020	1 Year
HX-EMC006	Positioning Controller	C&C	CC-C-1F	N/A	N/A
<b>3.4. Test Equipment Used to Measure Harmonic Current/ Voltage Fluctuation and Flicker</b>					
<b>No.</b>	<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Last Cal.</b>	<b>Cal. Interval</b>
HX-EMC007	Harmonic Flicker Test System	CI	5001ix-CTS-40	Jan.02, 2020	1 Year
<b>3.5. Test Equipment Used to Measure Electrostatic Discharge Immunity</b>					
<b>No.</b>	<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No.</b>	<b>Last Cal.</b>	<b>Cal. Interval</b>
HX-EMC008	ESD Tester	TESEQ	NSG437	Jan.02, 2020	1 Year
<b>3.6. Test Equipment Used to Measure Conducted Immunity</b>					
HX-EMC009	RF Generator	FRANKONIA	CIT-10/75	Jan.02, 2020	1 Year
HX-EMC010	Attenuator	FRANKONIA	59-6-33	Jan.02, 2020	1 Year
HX-EMC011	M-CDN	LUTHI	M2/M3	Jan.02, 2020	1 Year
HX-EMC012	CDN	LUTHI	AF2	Jan.02, 2020	1 Year
HX-EMC013	EM Injection Clamp	LUTHI	EM101	Jan.02, 2020	1 Year

**3.7. Test Equipment Used to Measure Radio Frequency Electromagnetic Fields Immunity**

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC014	Signal Generator	Rohde & Schwarz	SMT03	Jan.02, 2020	1 Year
HX-EMC015	Power Meter	Rohde & Schwarz	NRVD	Jan.02, 2020	1 Year
HX-EMC016	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.02, 2020	1 Year
HX-EMC017	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.02, 2020	1 Year
HX-EMC018	Power Amplifier	AR	150W1000	Jan.02, 2020	1 Year
HX-EMC019	Bilog Antenna	Chase	CBL6111C	Jan.02, 2020	1 Year

**3.8. Test Equipment Used to Measure Electrical Fast Transient/Burst Immunity**

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC020	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC021	Auto-transformer	EMTEST	V4780S2	Jan.02, 2020	1 Year

**3.9. Test Equipment Used to Measure Surge Immunity**

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.02, 2020	1 Year

**3.10. Test Equipment Used to Measure Voltage Dips and Interruptions Immunity**

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.02, 2020	1 Year

## 4. Conducted Emission Test

### 4.1. Test Standard and Limit

#### 4.1.1. Test Standard

EN 55014-1: 2017.

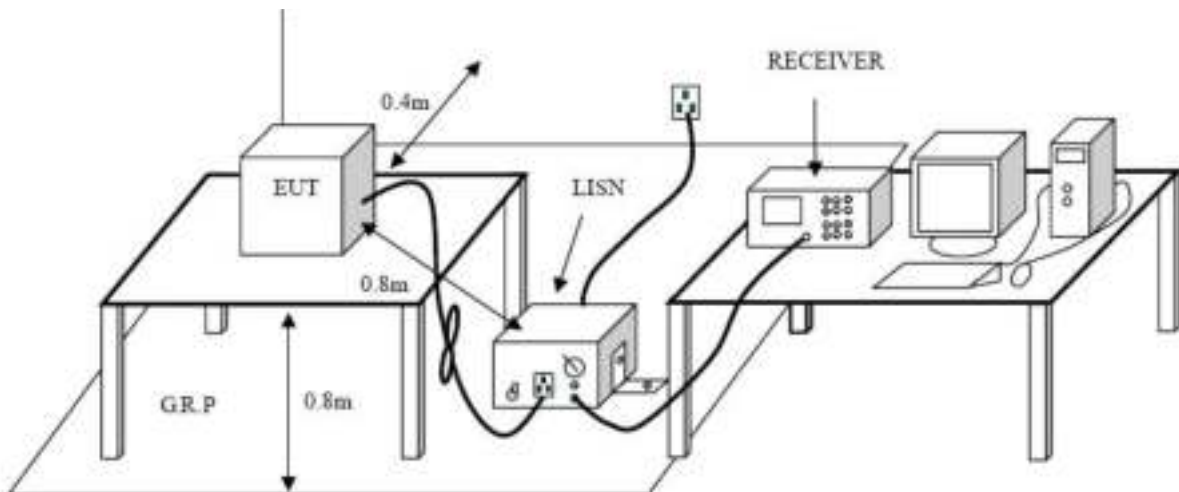
#### 4.1.2. Test Limit

Conducted Disturbance Test Limit

Frequency	Maximum RF Line Voltage (dB $\mu$ V)	
	Quasi-peak Level	Average Level
150kHz~350kHz	66 ~ 56*	56 ~ 46 *
350kHz~5MHz	56	46
5MHz~30MHz	60	50

**Remark:** "\*" Decreasing linearly with logarithm of the frequency

### 4.2. Test Setup



### 4.3. Test Procedure

The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.

Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.

I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.



LISN at least 80 cm from nearest part of EUT chassis.

The bandwidth of EMI test receiver is set at 9kHz, and the test frequency band is from 0.15MHz to 30MHz.

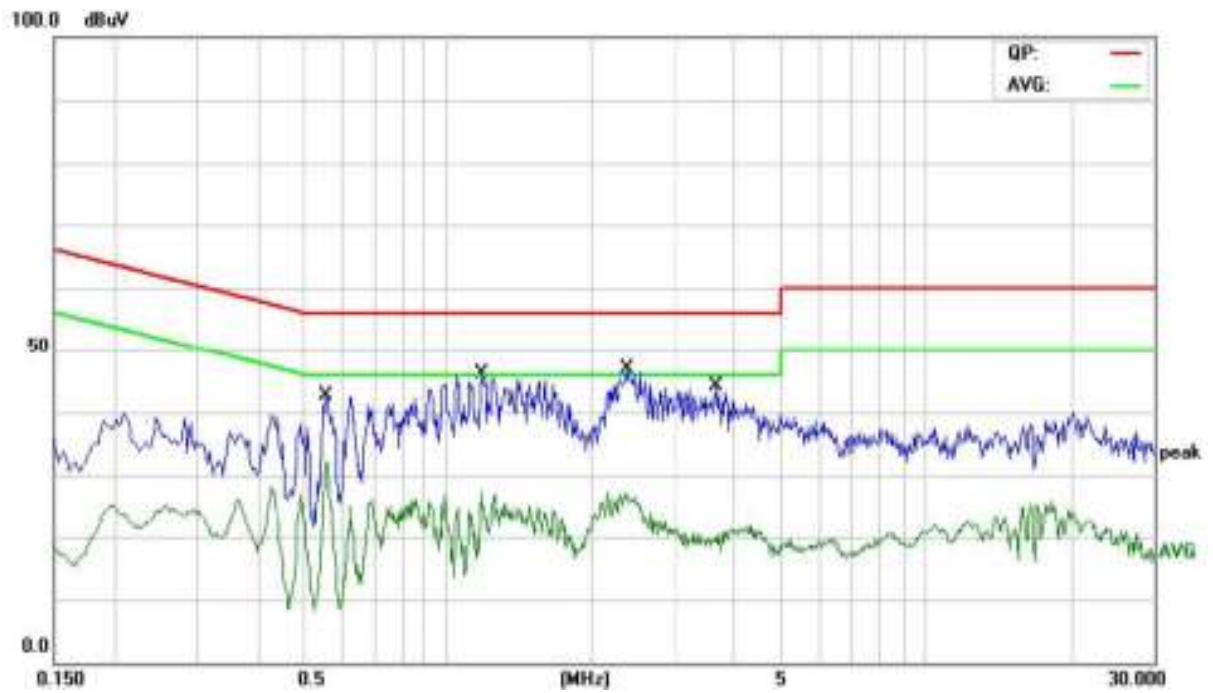
#### 4.4. Test Condition

Temperature	:	25 °C
Relative Humidity	:	48 %
Pressure	:	1010 hPa
Test Power	:	DC 3V

#### 4.5. Test Data

Please refer to the following pages.

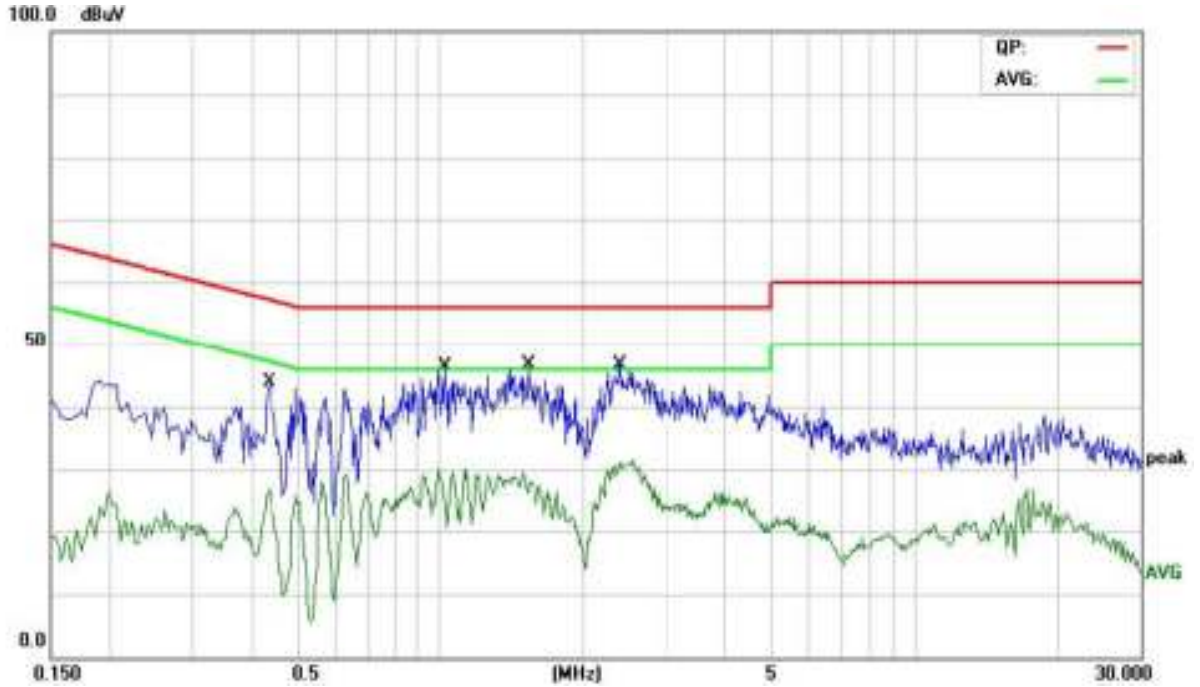
**Operating Condition: Normal**  
**Test Specification: L**



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1		0.5540	19.75	9.46	29.21	46.00	-16.79	AVG	
2		0.5580	33.09	9.45	42.54	56.00	-13.46	QP	
3		1.1780	36.83	9.34	46.17	56.00	-9.83	QP	
4		1.1820	15.45	9.34	24.79	46.00	-21.21	AVG	
5	*	2.3620	37.57	9.38	46.95	56.00	-9.05	QP	
6		2.3820	17.38	9.38	26.76	46.00	-19.24	AVG	
7		3.6420	34.62	9.44	44.06	56.00	-11.94	QP	
8		3.6420	10.34	9.44	19.78	46.00	-26.22	AVG	

**Operating Condition: Normal**

**Test Specification: N**



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1		0.4340	34.37	9.60	43.97	57.18	-13.21	QP	
2		0.4351	16.39	9.59	25.98	47.15	-21.17	AVG	
3		1.0220	36.94	9.33	46.27	56.00	-9.73	QP	
4		1.0220	15.89	9.33	25.22	46.00	-20.78	AVG	
5		1.5339	37.20	9.35	46.55	56.00	-9.45	QP	
6		1.5339	17.20	9.35	26.55	46.00	-19.45	AVG	
7	*	2.3940	37.26	9.38	46.64	56.00	-9.36	QP	
8		2.3940	21.18	9.38	30.56	46.00	-15.44	AVG	

## 5. Radiated Emission Test

### 5.1. Test Standard and Limit

#### 5.1.1. Test Standard

EN 55014-1: 2017.

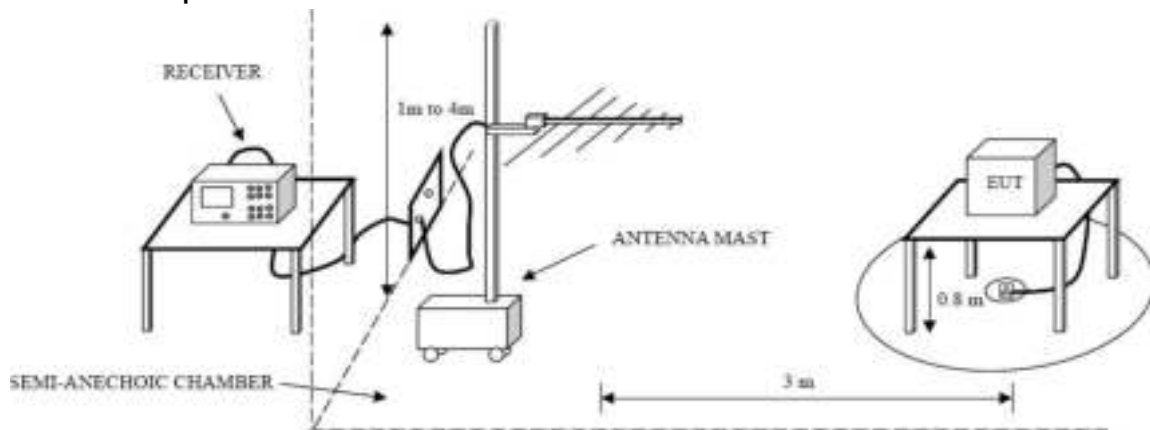
#### 5.1.2. Test Limit

Radiated Disturbance Test Limit

Frequency	Limit (dB $\mu$ V/m)
	Quasi-peak Level
30MHz~230MHz	40
230MHz~1000MHz	47

**Remark:** 1. The lower limit shall apply at the transition frequency.  
2. The test distance is 3m.

### 5.2. Test Setup



### 5.3. Test Procedure

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation.

The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.

#### 5.4. Test Condition

Temperature	:	23 °C
Relative Humidity	:	52 %
Pressure	:	1010 hPa
Test Power	:	DC 3V

#### 5.5. Test Data

Please refer to the following pages.

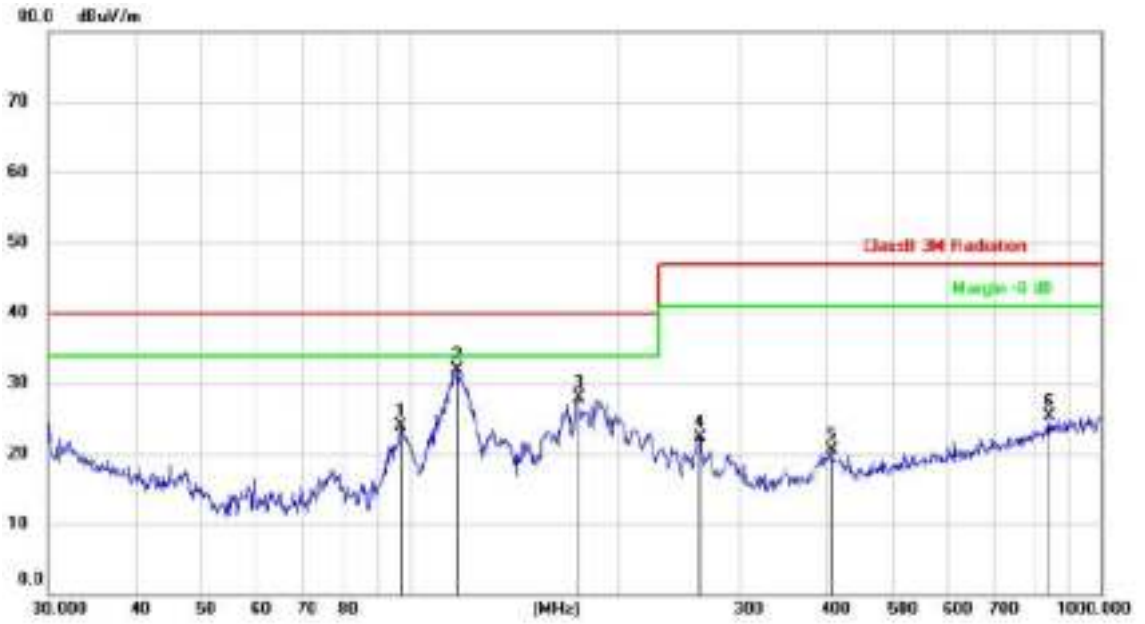
**Operating Condition: Normal**  
**Test Specification: Horizontal**



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dBuV/m	Measure- ment dBuV/m	Limit dBuV/m	Over dB	Detector
1		35.7490	46.18	-15.04	31.14	40.00	-8.86	QP
2	*	46.8303	46.21	-12.69	33.52	40.00	-6.48	QP
3		59.8588	38.80	-14.15	24.65	40.00	-15.35	QP
4		118.1860	45.90	-15.78	30.12	40.00	-9.88	QP
5		173.8135	45.61	-16.17	29.44	40.00	-10.56	QP
6		432.5457	30.81	-8.07	22.74	47.00	-24.26	QP

**Operating Condition: Normal**

**Test Specification: Vertical**



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dBuV/m	Measure- ment dBuV/m	Limit dBuV/m	Over dB	Detector
1		97.1148	38.73	-14.92	23.81	40.00	-16.19	QP
2	*	117.3602	47.61	-15.64	31.97	40.00	-8.03	QP
3		175.6516	44.04	-16.06	27.98	40.00	-12.02	QP
4		262.8955	33.97	-11.66	22.31	47.00	-24.69	QP
5		407.5144	28.85	-8.43	20.42	47.00	-26.58	QP
6		842.1295	27.43	-2.16	25.27	47.00	-21.73	QP



## 6. Electrostatic Discharge Immunity Test

### 6.1. Test Requirements

#### 6.1.1. Test Standard

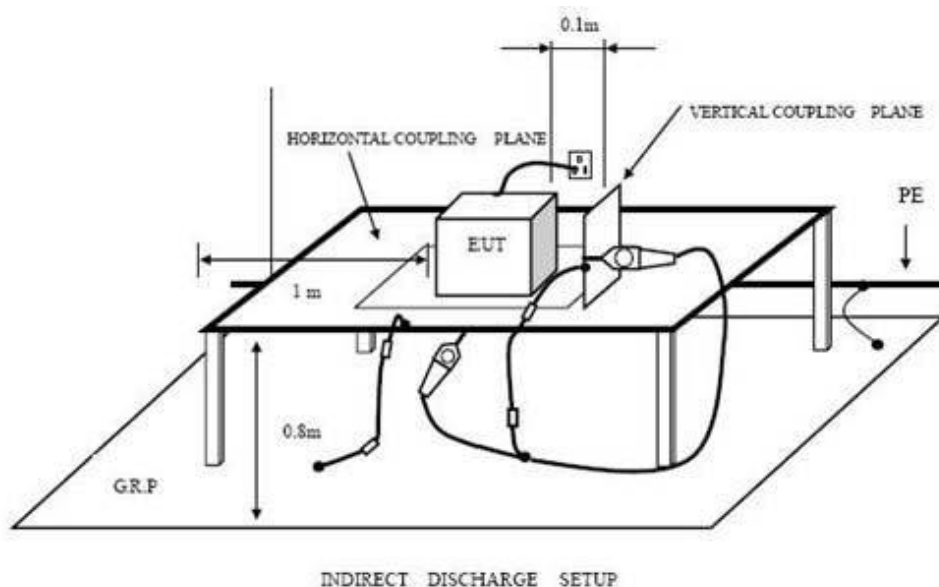
EN 55014-2: 2015 (EN 61000-4-2:2009)

#### 6.1.2. Test Level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.0	±2	±2
2.0	±4	±4
3.0	±6	±8
4.0	±8	±15
X	Special	Special

#### 6.1.3. Performance criterion: B

### 6.2. Test Setup



### 6.3. Test Procedure

#### 6.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 6.3.2. Contact Discharge:



All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

#### 6.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

#### 6.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

### 6.4. Test Data

Please refer to the following page.

## Electrostatic Discharge Test Result

EUT : <u>Facial Cleansing Brush</u>	M/N : <u>GT1933</u>	
Temperature : <u>22°C</u>	Humidity : <u>50%</u>	
Power supply : <u>DC 3V</u>	Test Mode : <u>Normal</u>	
Criterion: B		
Air Discharge: ±8kV Contact Discharge: ±4kV		
For each point positive 10 times and negative 10 times discharge.		
Location	Kind A-Air Discharge C-Contact Discharge	Result
Nonconductive Enclosure	A	PASS
Button	A	PASS
Conductive Enclosure	C	PASS
HCP	C	PASS
VCP of front	C	PASS
VCP of rear	C	PASS
VCP of left	C	PASS
VCP of right	C	PASS
<b>Remark:</b>		

## 7. Radiated Electromagnetic Field Immunity test

### 7.1. Test Requirements

#### 7.1.1. Test Standard

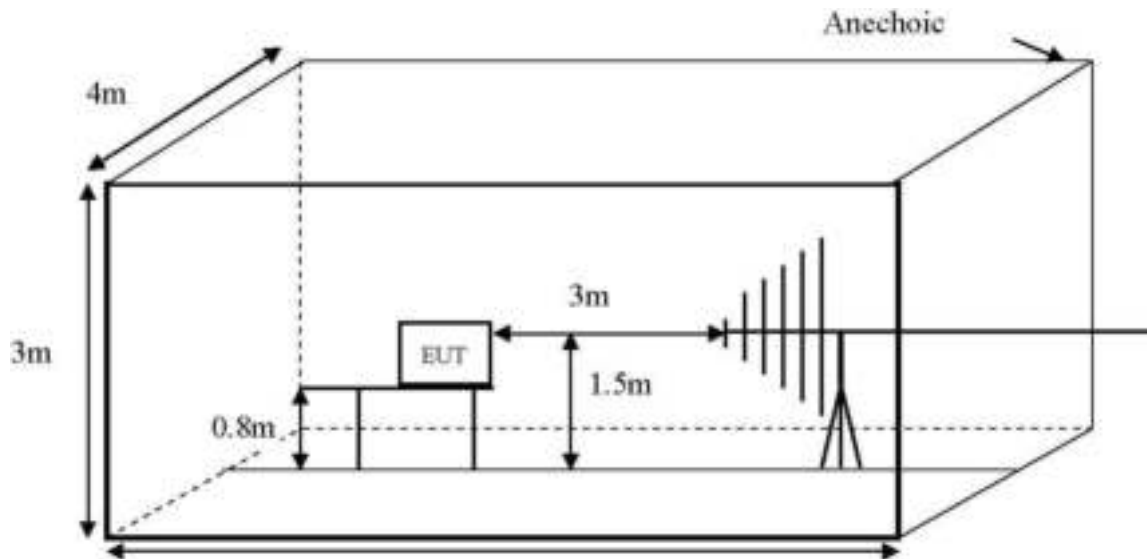
EN55014-2: 2015 (EN 61000-4-3: 2006 + A1: 2008 + A2:2010)

#### 7.1.2. Test Level

Level	Field Strength V/m
1.0	1
2.0	3
3.0	10
X	Special

#### 7.1.3. Performance criterion: A

### 7.2. Test Setup



### 7.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:

Condition of Test	Remark
1. Fielded Strength	3V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80-1000MHz
4. Sweep time of radiated	0.0015 Decade/s
5. Dwell Time	1 Sec.

#### 7.4. Test Data

Please refer to the following page.

## RF Field Strength Susceptibility Test Results

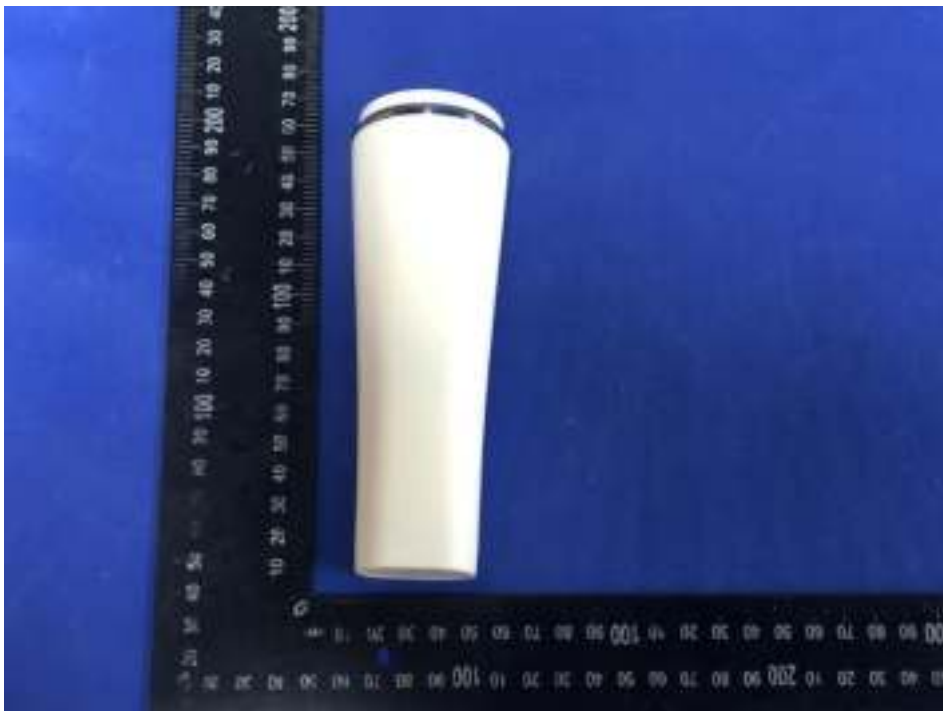
EUT	: <u>Facial Cleansing Brush</u>	M/N	: <u>GT1933</u>	
Temperature	: <u>22°C</u>	Humidity	: <u>50%</u>	
Power supply	: <u>DC 3V</u>	Test Mode	: <u>Normal</u>	
Criterion: A				
Modulation: Unmodulated				
Pulse: AM 1KHz 80%				
	Frequency Range 1		Frequency Range 2	
	80~1000MHz		/	
	Horizontal	Vertical	Horizontal	Vertical
Front	PASS	PASS	/	/
Right	PASS	PASS	/	/
Rear	PASS	PASS	/	/
Left	PASS	PASS	/	/

## 8. Photographs - Constructional Details

Photo 1 Appearance of EUT



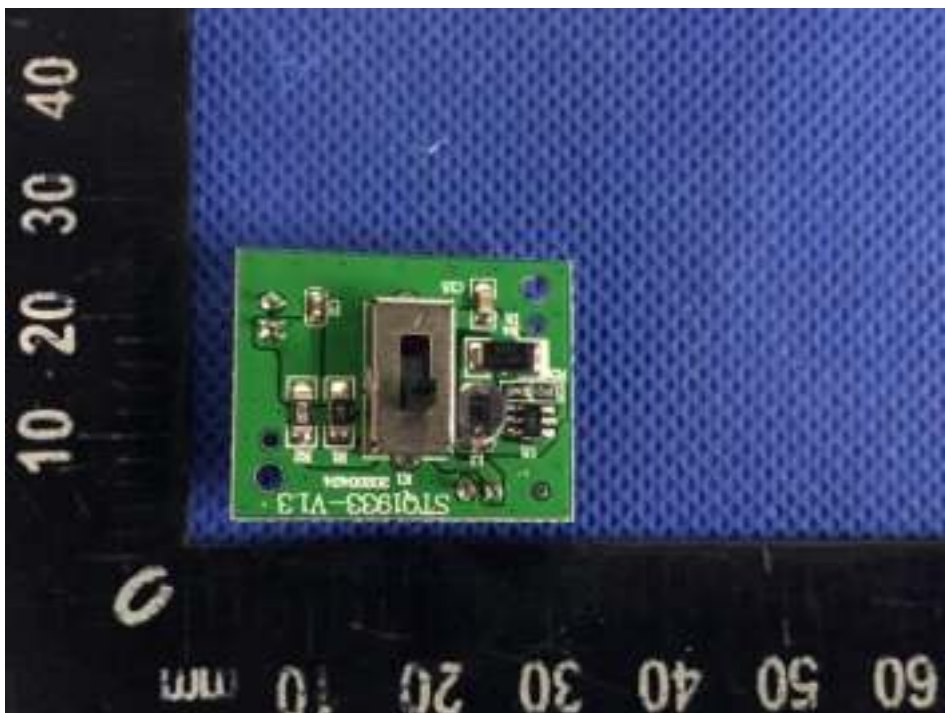
Photo 2 Appearance of EUT



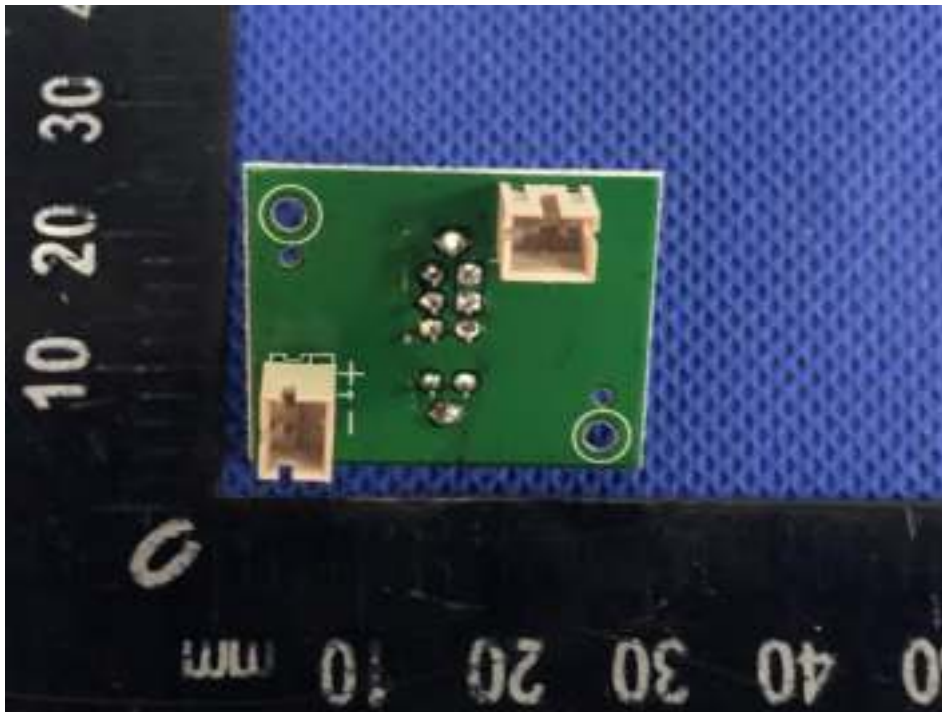
**Photo 3 Appearance of EUT**



**Photo 4 Appearance of EUT**



**Photo 5 Appearance of EUT**



END OF REPORT